

## Silicon N-Channel Power MOSFET

### General Description :

HMM170N30, the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is SOT-227B, which accords with the RoHS standard.

### Features :

- Fast Switching
- ESD Improved Capability
- Low Gate Charge
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

### Applications:

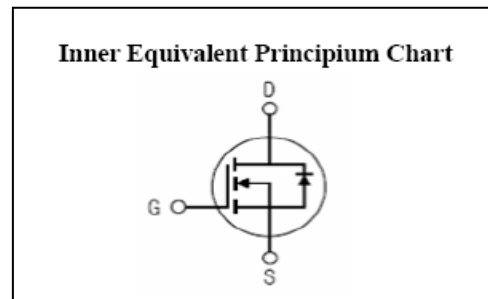
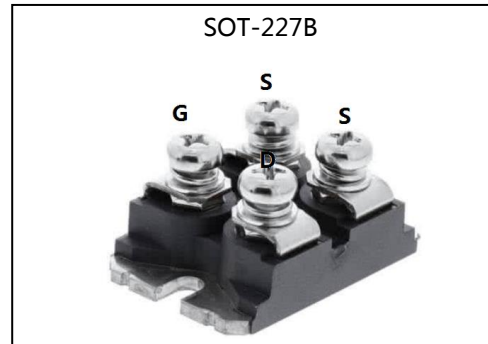
- Power switch circuit of POWER

### Absolute ( Tc=25°C unless otherwise specified ) :

Symbol	Parameter	Rating	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	300	V
I <sub>D</sub>	Continuous Drain Current	170	A
	Continuous Drain Current T <sub>C</sub> =100 °C	120	A
I <sub>DM</sub> <sup>a1</sup>	Pulsed Drain Current	600	A
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy	6	J
E <sub>Ar</sub> <sup>a1</sup>	Avalanche Energy ,Repetitive	600	mJ
I <sub>AR</sub> <sup>a1</sup>	Avalanche Current	100	A
dv/dt <sup>a2</sup>	Peak Diode Recovery dv/dt	5.0	V/ns
P <sub>D</sub>	Power Dissipation	890	W
	Derating Factor above 25°C	7.12	W/°C
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	150 , -55 to 150	°C
T <sub>L</sub>	Maximum Temperature for Soldering	300	°C

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device

V <sub>DSS</sub> (T <sub>C</sub> =150°C)	300	V
I <sub>D</sub>	170	A
P <sub>D</sub> (T <sub>C</sub> =25°C)	890	W
R <sub>DS(ON)TYP</sub>	17	mΩ



**Thermal Characteristics**

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.15	°C/ W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	0.05	°C/ W

**Electrical Characteristics (  $T_c = 25^\circ\text{C}$  unless otherwise specified ) :**

<b>OFF Characteristics</b>						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	300	--	--	V
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=300V, V_{GS}=0V, T_a=25^\circ\text{C}$	--	--	10	$\mu A$
		$V_{DS}=240V, V_{GS}=0V, T_a=125^\circ\text{C}$	--	--	1000	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30V$	--	--	200	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30V$	--	--	-200	nA

<b>ON Characteristics</b>						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=30A$	--	13	17	m $\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	--	4.0	V
$g_{fs}$	Forward Trans conductance	$V_{DS}=30V, I_D=30A$	--	110	--	S

Pulse width < 380 $\mu$ s; duty cycle < 2%.

<b>Dynamic Characteristics</b>						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=25V$ $f=1.0\text{MHz}$	--	12000	--	pF
$C_{oss}$	Output Capacitance		--	1850	--	
$C_{rss}$	Reverse Transfer Capacitance		--	120	--	

<b>Resistive Switching Characteristics</b>						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=85A, V_{DD}=150V$ $V_{GS}=10V, R_g=1\Omega$	--	45	--	ns
$t_r$	Rise Time		--	36	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	96	--	
$t_f$	Fall Time		--	33	--	
$Q_g$	Total Gate Charge	$I_D=85A, V_{DD}=150V$ $V_{GS}=10V$	--	260	--	nC
$Q_{gs}$	Gate to Source Charge		--	55	--	
$Q_{gd}$	Gate to Drain ( "Miller" ) Charge		--	90	--	

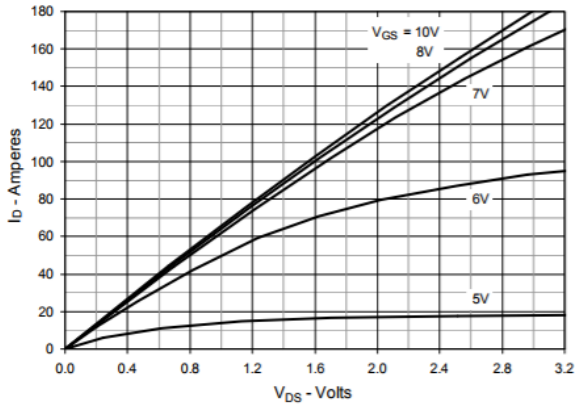
Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_{SD}$	Continuous Source Current (Body Diode)		--	--	170	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	600	A
$V_{SD}$	Diode Forward Voltage	$I_S=85A, V_{GS}=0V$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S=85A, T_j=25^\circ C$	--	360	--	ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt=100A/\mu s,$ $V_{GS}=0V$	--	7,2	--	$\mu C$

a1 : Repetitive rating; pulse width limited by maximum junction temperature

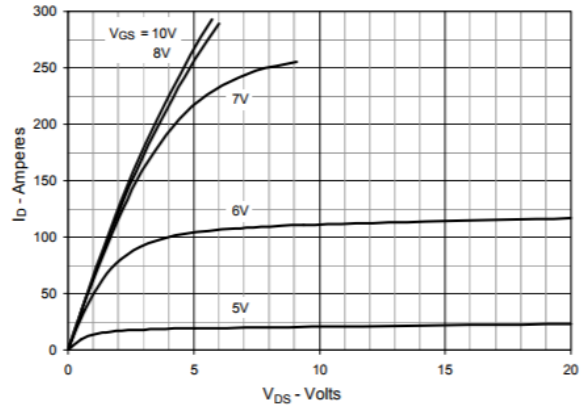
a2 :  $I_{SD}=170A, di/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS},$  Start  $T_j=25^\circ C$

## Characteristics Curve :

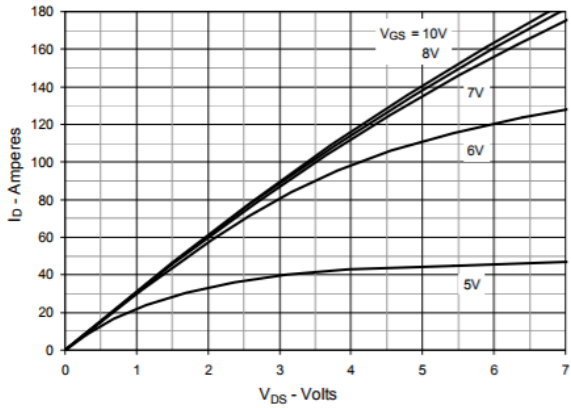
**Fig. 1. Output Characteristics @  $T_J = 25^\circ\text{C}$**



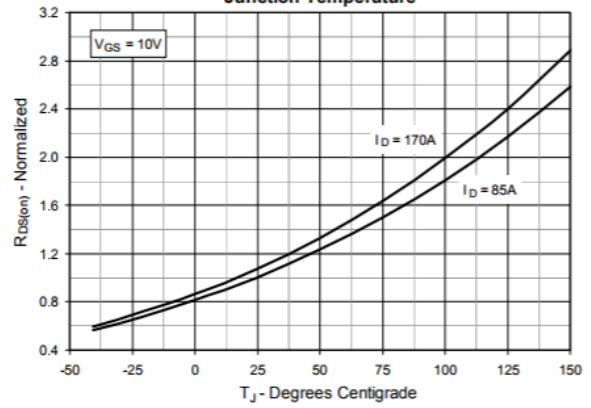
**Fig. 2. Extended Output Characteristics @  $T_J = 25^\circ\text{C}$**



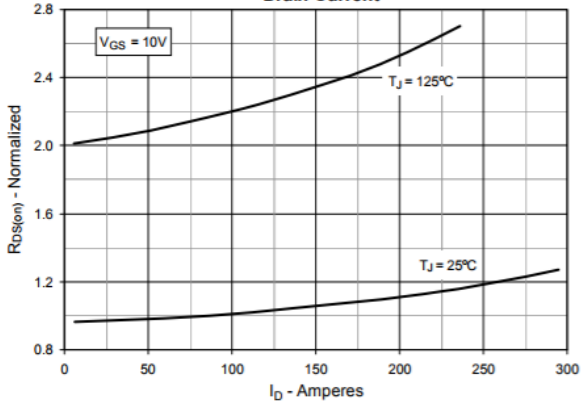
**Fig. 3. Output Characteristics @  $T_J = 125^\circ\text{C}$**



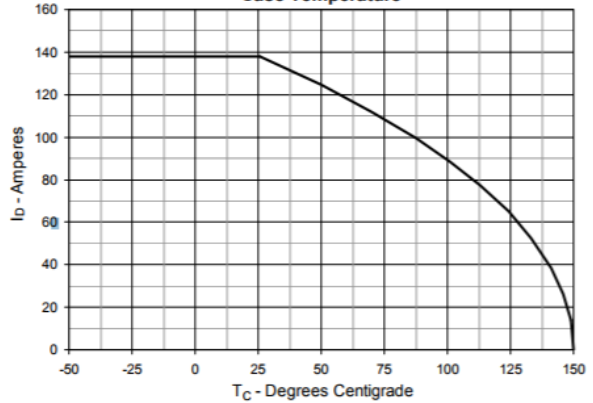
**Fig. 4.  $R_{DS(on)}$  Normalized to  $I_D = 85\text{A}$  Value vs. Junction Temperature**



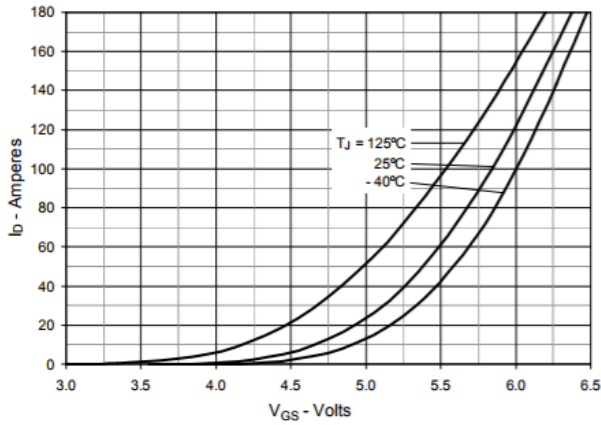
**Fig. 5.  $R_{DS(on)}$  Normalized to  $I_D = 85\text{A}$  Value vs. Drain Current**



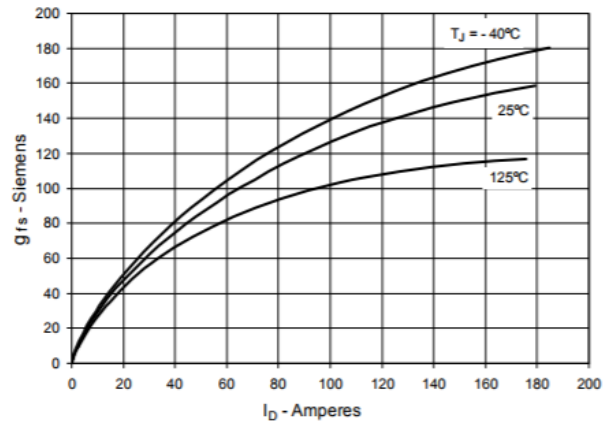
**Fig. 6. Maximum Drain Current vs. Case Temperature**



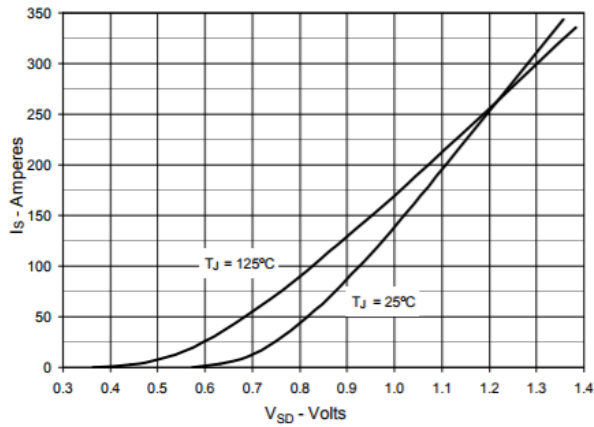
**Fig. 7. Input Admittance**



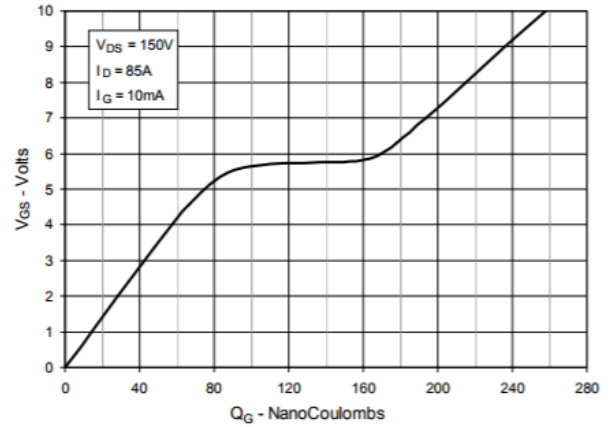
**Fig. 8. Transconductance**



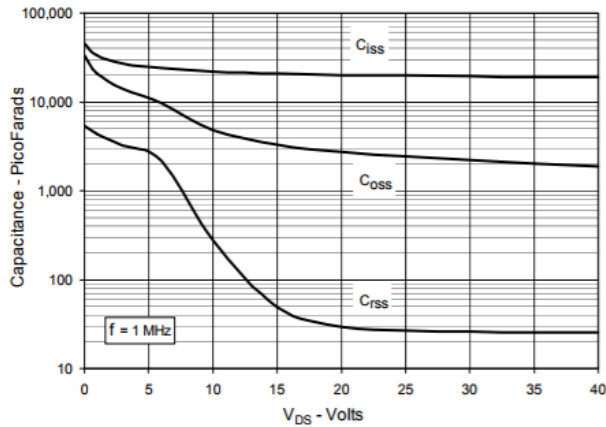
**Fig. 9. Forward Voltage Drop of Intrinsic Diode**



**Fig. 10. Gate Charge**



**Fig. 11. Capacitance**



**Fig. 12. Forward-Bias Safe Operating Area**

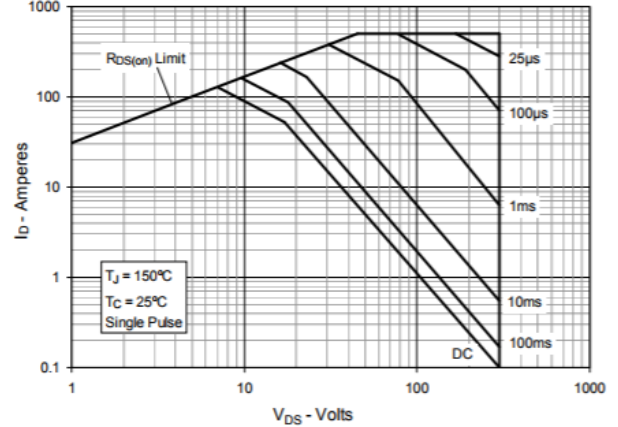


Fig. 13. Maximum Transient Thermal Impedance

